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	U.S. DEPARTMENT OF COMMERCE			ATTY. DOCKET NO.		APPLICATION NO.					
(REV. 05/03)	05/03) PATENT AND TRADEMARK OFFICE			INDUM-110XX		10/636,105					
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EXAMINER	DOCUMENT NUMBER	PUBLICATION/	NAME		CLASS	SUBCLASS	FILING	DATE			
INITIAL		ISSUE DATE									
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EXAMINER											
*EXAMINER: Initial if citation considered, whether of not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.											



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